

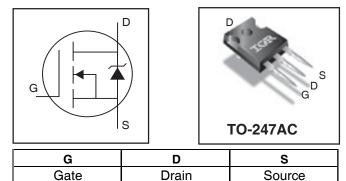
PDP SWITCH

IRFP4227PbF

Features

- Advanced Process Technology
- Key Parameters Optimized for PDP Sustain, Energy Recovery and Pass Switch Applications
- Low E_{PULSE} Rating to Reduce Power
 Dissipation in PDP Sustain, Energy Recovery and Pass Switch Applications
- Low Q_G for Fast Response
- High Repetitive Peak Current Capability for Reliable Operation
- Short Fall & Rise Times for Fast Switching
- •175°C Operating Junction Temperature for Improved Ruggedness
- Repetitive Avalanche Capability for Robustness and Reliability

Key Parameters					
V _{DS} max	200	V			
V _{DS (Avalanche)} typ.	240	V			
R _{DS(ON)} typ. @ 10V	21	mΩ			
I _{RP} max @ T _C = 100°C	130	Α			
T _J max	175	°C			



Description

This HEXFET® Power MOSFET is specifically designed for Sustain; Energy Recovery & Pass switch applications in Plasma Display Panels. This MOSFET utilizes the latest processing techniques to achieve low on-resistance per silicon area and low E_{PULSE} rating. Additional features of this MOSFET are 175°C operating junction temperature and high repetitive peak current capability. These features combine to make this MOSFET a highly efficient, robust and reliable device for PDP driving applications.

Absolute Maximum Ratings

Parameter		Max.	Units	
V _{GS}	Gate-to-Source Voltage	±30	V	
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V	65	А	
I _D @ T _C = 100°C	Continuous Drain Current, V _{GS} @ 10V	46		
I _{DM}	Pulsed Drain Current ①	260		
I _{RP} @ T _C = 100°C	Repetitive Peak Current ⑤	130		
P _D @T _C = 25°C	Power Dissipation	330	W	
P _D @T _C = 100°C	Power Dissipation	190		
	Linear Derating Factor	2.2	W/°C	
T _J	Operating Junction and	-40 to + 175	°C	
T _{STG}	Storage Temperature Range			
	Soldering Temperature for 10 seconds	300		
	Mounting Torque, 6-32 or M3 Screw	10lb·in (1.1N·m)	N	

Thermal Resistance

	Parameter	Тур.	Max.	Units
$R_{\theta JC}$	Junction-to-Case 4		0.45	
$R_{\theta CS}$	Case-to-Sink, Flat, Greased Surface	0.50		°C/W
$R_{\theta JA}$	Junction-to-Ambient ®		62	

Notes ① through ⑥ are on page 8

Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
BV _{DSS}	Drain-to-Source Breakdown Voltage	200			V	$V_{GS} = 0V, I_{D} = 250\mu A$
$\Delta BV_{DSS}/\Delta T_{J}$	Breakdown Voltage Temp. Coefficient		170		mV/°C	Reference to 25°C, I _D = 1mA
R _{DS(on)}	Static Drain-to-Source On-Resistance		21	25	mΩ	V _{GS} = 10V, I _D = 46A ③
$V_{GS(th)}$	Gate Threshold Voltage	3.0		5.0	V	$V_{DS} = V_{GS}$, $I_D = 250\mu A$
$\Delta V_{GS(th)}/\Delta T_J$	Gate Threshold Voltage Coefficient		-13		mV/°C	
I _{DSS}	Drain-to-Source Leakage Current			20	μΑ	$V_{DS} = 200V, V_{GS} = 0V$
				1.0	mA	$V_{DS} = 200V, V_{GS} = 0V, T_{J} = 125^{\circ}C$
I _{GSS}	Gate-to-Source Forward Leakage			100	nA	$V_{GS} = 20V$
	Gate-to-Source Reverse Leakage			-100		$V_{GS} = -20V$
g _{fs}	Forward Transconductance	49			S	$V_{DS} = 25V, I_{D} = 46A$
Q_g	Total Gate Charge		70	98	nC	$V_{DD} = 100V, I_D = 46A, V_{GS} = 10V$
Q_{gd}	Gate-to-Drain Charge		23			
t _{d(on)}	Turn-On Delay Time		33			$V_{DD} = 100V, V_{GS} = 10V$ ③
t _r	Rise Time		20		ns	I _D = 46A
t _{d(off)}	Turn-Off Delay Time		21			$R_G = 2.5\Omega$
t _f	Fall Time		31			See Fig. 22
t _{st}	Shoot Through Blocking Time	100			ns	$V_{DD} = 160V, V_{GS} = 15V, R_{G} = 4.7\Omega$
			570			$L = 220$ nH, $C = 0.4$ µF, $V_{GS} = 15$ V
E _{PULSE}	Energy per Pulse		370		μJ	$V_{DS} = 160V, R_{G} = 4.7\Omega, T_{J} = 25^{\circ}C$
			910			$L = 220$ nH, $C = 0.4$ µF, $V_{GS} = 15$ V
			310			$V_{DS} = 160V, R_{G} = 4.7\Omega, T_{J} = 100^{\circ}C$
C _{iss}	Input Capacitance		4600			$V_{GS} = 0V$
C _{oss}	Output Capacitance		460		pF	$V_{DS} = 25V$
C _{rss}	Reverse Transfer Capacitance		91			f = 1.0MHz,
C _{oss} eff.	Effective Output Capacitance		360			$V_{GS} = 0V, V_{DS} = 0V \text{ to } 160V$
L _D	Internal Drain Inductance		5.0			Between lead,
					nH	6mm (0.25in.)
L _S	Internal Source Inductance		13			from package
						and center of die contact

Avalanche Characteristics

	Parameter	Тур.	Max.	Units	
E _{AS}	Single Pulse Avalanche Energy®		140	mJ	
E _{AR}	Repetitive Avalanche Energy ①		33	mJ	
V _{DS(Avalanche)}	Repetitive Avalanche Voltage ①	240		V	
I _{AS}	Avalanche Current ©		39	Α	

Diode Characteristics

	Parameter	Min.	Тур.	Max.	Units	Conditions	
I _S @ T _C = 25°C	Continuous Source Current			65		MOSFET symbol	
	(Body Diode)				Α	showing the	
I _{SM}	Pulsed Source Current			260		integral reverse	
	(Body Diode) ①					p-n junction diode.	
V_{SD}	Diode Forward Voltage			1.3	V	$T_J = 25$ °C, $I_S = 46A$, $V_{GS} = 0V$ ③	
t _{rr}	Reverse Recovery Time		100	150	ns	$T_J = 25^{\circ}C, I_F = 46A, V_{DD} = 50V$	
Q _{rr}	Reverse Recovery Charge		430	640	nC	di/dt = 100A/μs ③	

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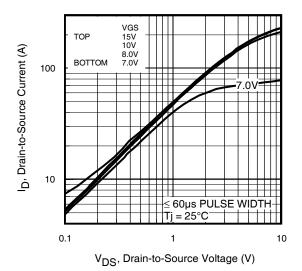


Fig 1. Typical Output Characteristics

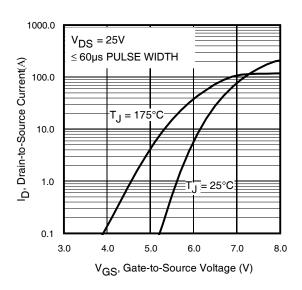


Fig 3. Typical Transfer Characteristics

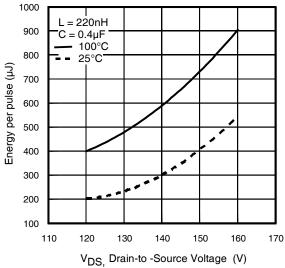


Fig 5. Typical E_{PULSE} vs. Drain-to-Source Voltage www.irf.com

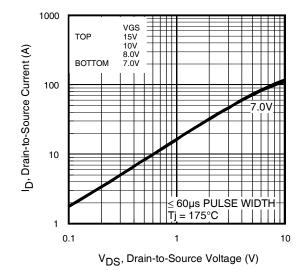


Fig 2. Typical Output Characteristics

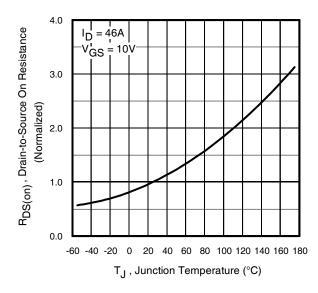


Fig 4. Normalized On-Resistance vs. Temperature

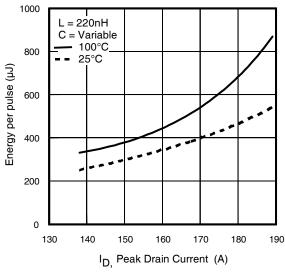


Fig 6. Typical E_{PULSE} vs. Drain Current

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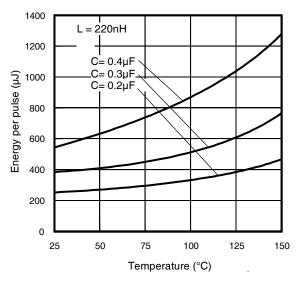
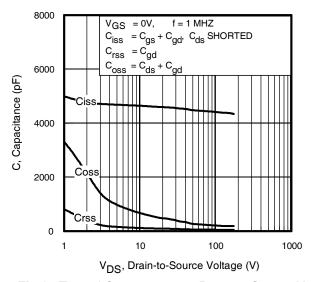


Fig 7. Typical E_{PULSE} vs.Temperature



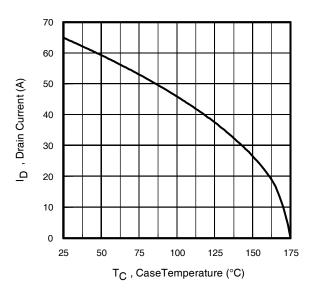


Fig 11. Maximum Drain Current vs. Case Temperature

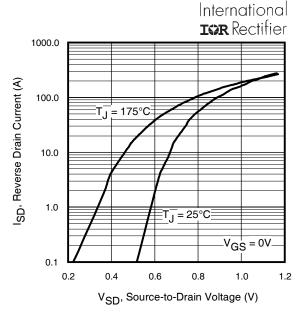


Fig 8. Typical Source-Drain Diode Forward Voltage

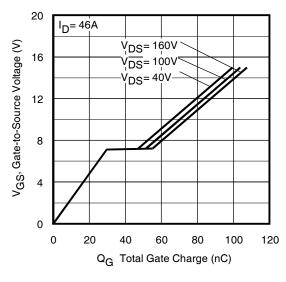


Fig 9. Typical Capacitance vs.Drain-to-Source Voltage Fig 10. Typical Gate Charge vs.Gate-to-Source Voltage

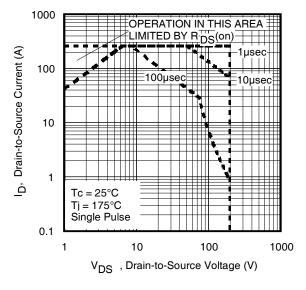


Fig 12. Maximum Safe Operating Area www.irf.com



IOR Rectifier

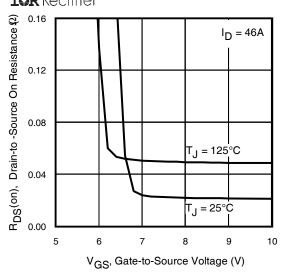


Fig 13. On-Resistance Vs. Gate Voltage

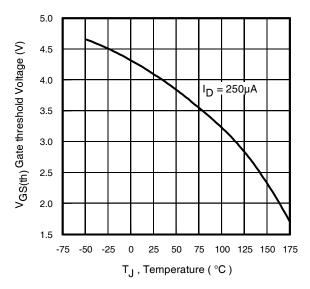


Fig 15. Threshold Voltage vs. Temperature

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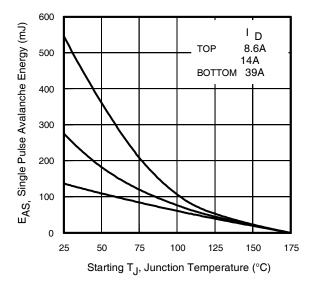


Fig 14. Maximum Avalanche Energy Vs. Temperature

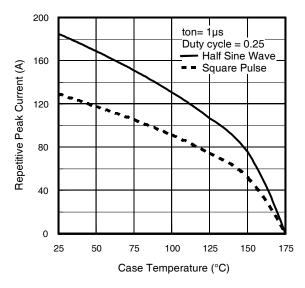


Fig 16. Typical Repetitive peak Current vs. Case temperature

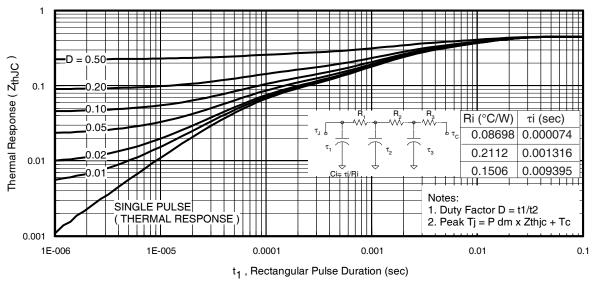


Fig 17. Maximum Effective Transient Thermal Impedance, Junction-to-Case

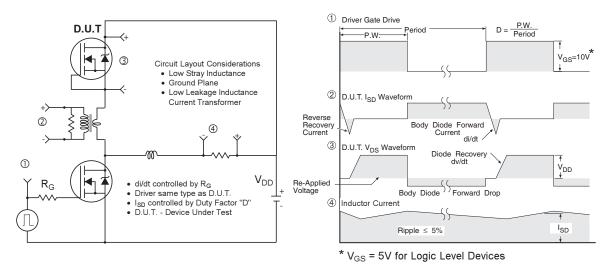


Fig 18. Diode Reverse Recovery Test Circuit for N-Channel HEXFET® Power MOSFETs

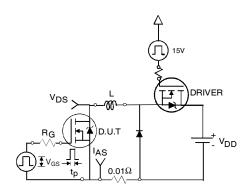


Fig 19a. Unclamped Inductive Test Circuit

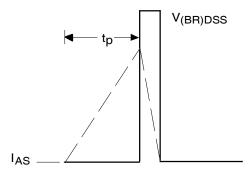


Fig 19b. Unclamped Inductive Waveforms

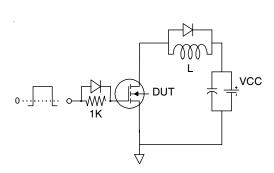


Fig 20a. Gate Charge Test Circuit

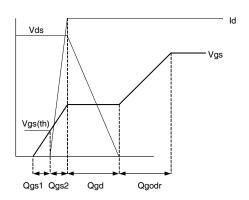


Fig 20b. Gate Charge Waveform

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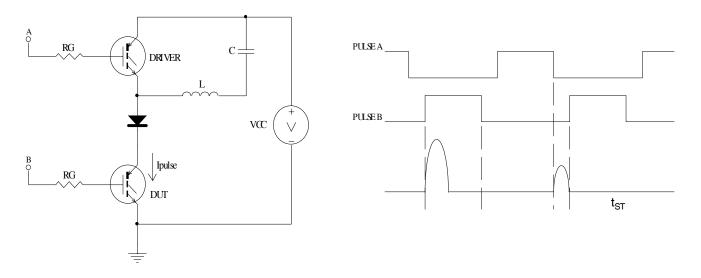


Fig 21a. $\rm t_{st}$ and $\rm E_{PULSE}$ Test Circuit

Fig 21b. t_{st} Test Waveforms

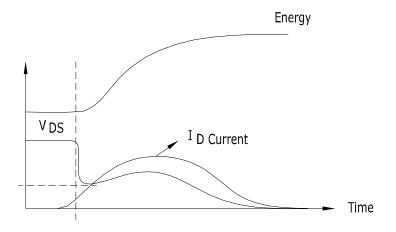


Fig 21c. E_{PULSE} Test Waveforms

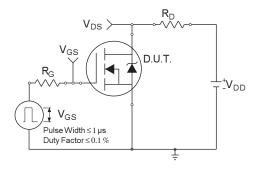


Fig 22a. Switching Time Test Circuit

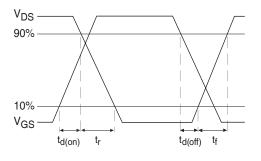
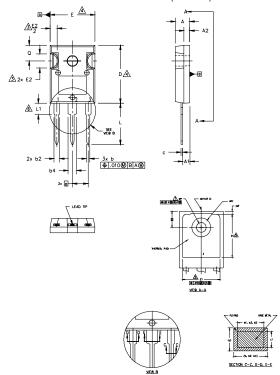


Fig 22b. Switching Time Waveforms

TO-247AC Package Outline

Dimensions are shown in millimeters (inches)



NOTES:

1. DIMENSIONING AND TOLERANCING AS PER ASME Y14.5M 1994.

2. DIMENSIONS ARE SHOWN IN INCHES.

CONTOUR OF SLOT OPTIONAL.

4 DIMENSION D & E DO NOT IN

DIMENSION D & E DO NOT INCLUDE MOLD FLASH, MOLD FLASH SHALL NOT EXCEED .005" (0.127)
PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY

THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSIONS D1 & E1.

LEAD FINISH UNCONTROLLED IN L1.

P TO HAVE A MAXIMUM DRAFT ANGLE OF 1.5 * TO THE TOP OF THE PART WITH A MAXIMUM HOLE DIAMETER OF .154 INCH.

8. OUTLINE CONFORMS TO JEDEC OUTLINE TO-247AC

		DIMEN	ISIONS			
SYMBOL	INC	HES	MILLIM	ETERS	1	
	MIN.	MAX.	MIN.	MAX.	NOTES	
A	.183	,209	4,65	5.31		1
A1	.087	.102	2,21	2.59		
A2	.059	.098	1,50	2.49		
b	.039	.055	0.99	1,40		
ь1	.039	.053	0.99	1.35		L
b2	.065	.094	1.65	2.39		
b3	.065	.092	1,65	2,34		
b4	.102	.135	2,59	3,43		
b5	.102	.133	2.59	3.38		
c	.015	.035	0,38	0.89		
c1	.015	.033	0.38	0.84		
D	.776	.815	19.71	20.70	4	
D1	.515	-	13.08	-	5	
D2	.020	.053	0.51	1.35		
E	.602	.625	15.29	15.87	4	
E1	,530	-	13,46	-		
E2	.178	.216	4,52	5.49		
e	.215	BSC	5.46	BSC	1	
Øk	.0	.010		25	1	
L	.559	.634	14,20	16.10	1	
L1	.146	.169	3.71	4.29		
øP	.140	.144	3.56	3.66	1	
øP1	-	.291	-	7.39		
Q	.209	.224	5,31	5,69		
S	.217	BSC	5,51	BSC		
	1		1			J

LEAD ASSIGNMENTS

1.- GATE 2.- DRAIN 3.- SOURCE

IGBTs, CoPACK

1,- GATE 2.- COLLECTOR 3.- EMITTER 4.- COLLECTOR

DIODES

1.- ANODE/OPEN 2.- CATHODE 3.- ANODE

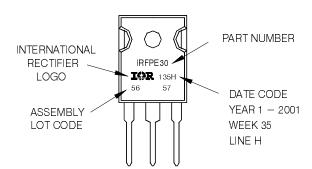
TO-247AC Part Marking Information

EXAMPLE: THIS IS AN IRFPE30

WITH ASSEMBLY LOT CODE 5657

ASSEMBLED ON WW 35, 2001 IN THE ASSEMBLY LINE "H"

Note: "P" in assembly line position indicates "Lead-Free"



TO-247AC package is not recommended for Surface Mount Application.

Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature.
- ② Starting $T_J = 25^{\circ}C$, L = 0.18mH, $R_G = 25\Omega$, $I_{AS} = 39A$.
- 4 R₀ is measured at T_J of approximately 90°C.
- (5) Half sine wave with duty cycle = 0.25, ton=1µsec.

Note: For the most current drawing please refer to IR website at: http://www.irf.com/package/

Data and specifications subject to change without notice. This product has been designed and qualified for the Industrial market.

Qualification Standards can be found on IR's Web site.



IR WORLD HEADQUARTERS: 233 Kansas St., El Segundo, California 90245, USA Tel: (310) 252-7105

TAC Fax: (310) 252-7903

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